



ALPHA & OMEGA
SEMICONDUCTOR

AOL1704

N-Channel Enhancement Mode Field Effect Transistor

SRFET™



General Description

SRFET™ AOL1704 uses advanced trench technology with a monolithically integrated Schottky diode to provide excellent $R_{DS(ON)}$, and low gate charge. This device is suitable for use as a low side FET in SMPS, load switching and general purpose applications. Standard Product AOL1704 is Pb-free (meets ROHS & Sony 259 specifications).

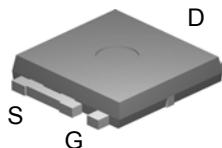
Features

$V_{DS} (V) = 30V$
 $I_D = 50A (V_{GS} = 10V)$
 $R_{DS(ON)} < 7.8m\Omega (V_{GS} = 10V)$
 $R_{DS(ON)} < 9.8m\Omega (V_{GS} = 4.5V)$

UIS Tested!

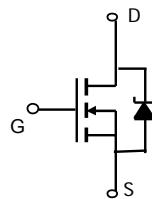
Rg, Ciss, Coss, Crss Tested

UltraSO-8™ Top View



Fits SOIC8
footprint !

Bottom tab
connected to
drain



SRFET™

Soft Recovery MOSFET:
Integrated Schottky Diode

Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

Parameter	Symbol	Maximum	Units
Drain-Source Voltage	V_{DS}	30	V
Gate-Source Voltage	V_{GS}	± 12	V
Continuous Drain Current ^B	I_D	50	A
$T_C=25^\circ\text{C}$		43	
Pulsed Drain Current	I_{DM}	120	
Continuous Drain Current ^H	I_{DSM}	18	A
$T_A=25^\circ\text{C}$		14	
Avalanche Current ^C	I_{AR}	25	A
Repetitive avalanche energy $L=0.3\text{mH}$ ^C	E_{AR}	94	mJ
Power Dissipation ^B	P_D	50	W
$T_C=100^\circ\text{C}$		25	
Power Dissipation ^A	P_{DSM}	4.3	W
$T_A=70^\circ\text{C}$		2.8	
Junction and Storage Temperature Range	T_J, T_{STG}	-55 to 175	°C

Thermal Characteristics

Parameter	Symbol	Typ	Max	Units
Maximum Junction-to-Ambient ^A	$R_{\theta JA}$	24	29	°C/W
Steady-State		53	64	°C/W
Maximum Junction-to-Case ^C	$R_{\theta JC}$	2.4	3.0	°C/W

Electrical Characteristics ($T_J=25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
STATIC PARAMETERS						
BV_{DSS}	Drain-Source Breakdown Voltage	$I_D=250\mu\text{A}, V_{GS}=0\text{V}$	30			V
$I_{\text{DS}}_{\text{SS}}$	Zero Gate Voltage Drain Current	$V_{DS}=24\text{V}, V_{GS}=0\text{V}$ $T_J=125^\circ\text{C}$		0.04	0.1	mA
I_{GSS}	Gate-Body leakage current	$V_{DS}=0\text{V}, V_{GS}=\pm 12\text{V}$		5	20	μA
$V_{\text{GS}(\text{th})}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=250\mu\text{A}$	1.4	1.8	2.4	V
$I_{\text{D}(\text{ON})}$	On state drain current	$V_{GS}=4.5\text{V}, V_{DS}=5\text{V}$	120			A
$R_{\text{DS}(\text{ON})}$	Static Drain-Source On-Resistance	$V_{GS}=10\text{V}, I_D=20\text{A}$ $T_J=125^\circ\text{C}$		6.5	7.8	$\text{m}\Omega$
		$V_{GS}=4.5\text{V}, I_D=20\text{A}$		9.2	11.5	$\text{m}\Omega$
g_{FS}	Forward Transconductance	$V_{DS}=5\text{V}, I_D=20\text{A}$		8	9.8	$\text{m}\Omega$
V_{SD}	Diode Forward Voltage	$I_S=1\text{A}, V_{GS}=0\text{V}$		0.36	0.5	V
I_S	Maximum Body-Diode + Schottky Diode Continuous Current ¹			50		A
DYNAMIC PARAMETERS						
C_{iss}	Input Capacitance	$V_{GS}=0\text{V}, V_{DS}=15\text{V}, f=1\text{MHz}$		2800	3640	pF
C_{oss}	Output Capacitance			390		pF
C_{rss}	Reverse Transfer Capacitance			145		pF
R_g	Gate resistance	$V_{GS}=0\text{V}, V_{DS}=0\text{V}, f=1\text{MHz}$		0.8	1.2	Ω
SWITCHING PARAMETERS						
$Q_g(10\text{V})$	Total Gate Charge	$V_{GS}=10\text{V}, V_{DS}=15\text{V}, ID=20\text{A}$		42	50	
$Q_g(4.5\text{V})$	Total Gate Charge			19	23	nC
Q_{gs}	Gate Source Charge			7		nC
Q_{gd}	Gate Drain Charge			6		nC
$t_{\text{D}(\text{on})}$	Turn-On Delay Time	$V_{GS}=10\text{V}, V_{DS}=15\text{V}, R_L=0.75\Omega, R_{\text{GEN}}=3\Omega$		7		ns
t_r	Turn-On Rise Time			7		ns
$t_{\text{D}(\text{off})}$	Turn-Off Delay Time			31		ns
t_f	Turn-Off Fall Time			5		ns
t_{rr}	Body Diode Reverse Recovery Time	$I_F=20\text{A}, dI/dt=300\text{A}/\mu\text{s}$		13	16	ns
Q_{rr}	Body Diode Reverse Recovery Charge	$I_F=20\text{A}, dI/dt=300\text{A}/\mu\text{s}$		12		nC

A: The value of R_{GJA} is measured with the device in a still air environment with $T_A=25^\circ\text{C}$. The power dissipation P_{DSM} and current rating I_{DSM} are based on $T_{J(\text{MAX})}=150^\circ\text{C}$, using $t \leq 10\text{s}$ junction-to-ambient thermal resistance.

B. The power dissipation P_D is based on $T_{J(\text{MAX})}=175^\circ\text{C}$, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C: Repetitive rating, pulse width limited by junction temperature $T_{J(\text{MAX})}=175^\circ\text{C}$.

D. The R_{GJA} is the sum of the thermal impedance from junction to case R_{JC} and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using $<300\text{ }\mu\text{s}$ pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of $T_{J(\text{MAX})}=175^\circ\text{C}$.

G. These tests are performed with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^\circ\text{C}$. The SOA curve provides a single pulse rating.

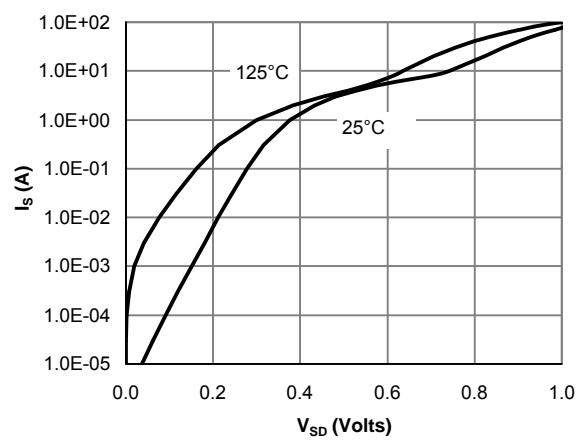
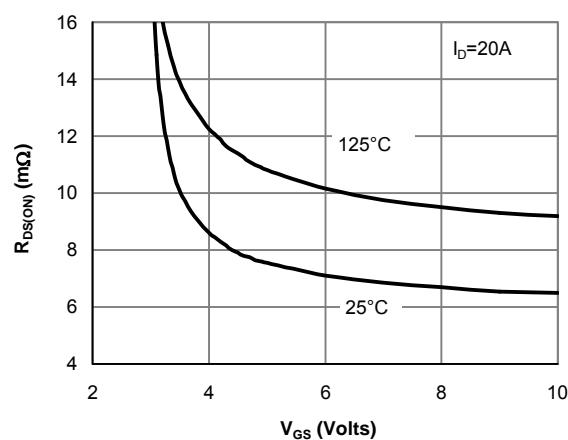
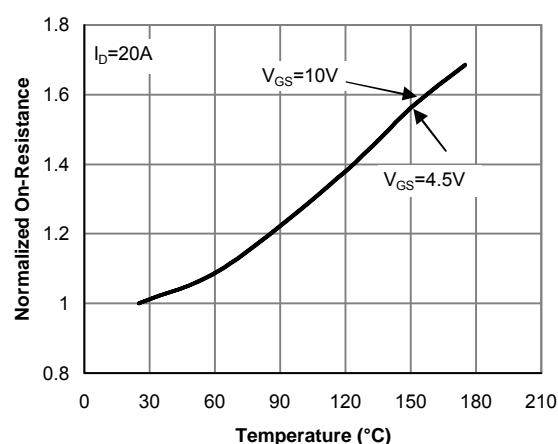
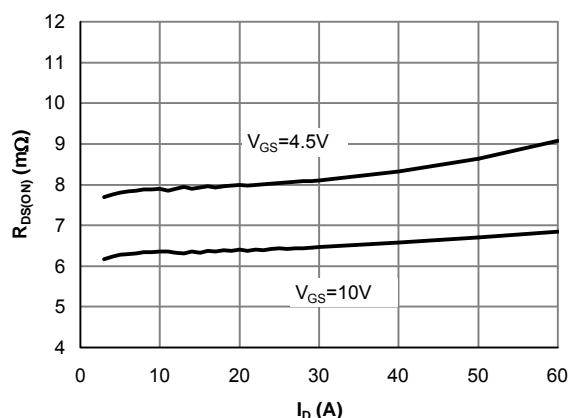
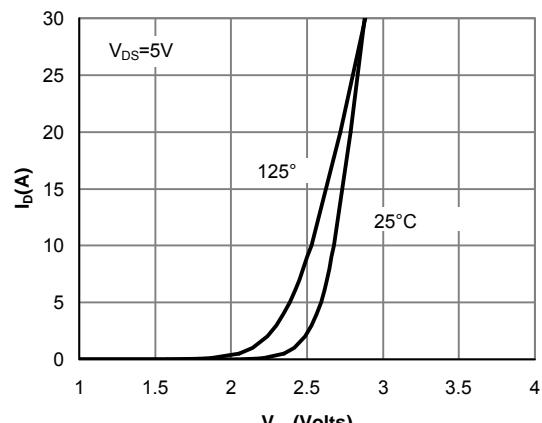
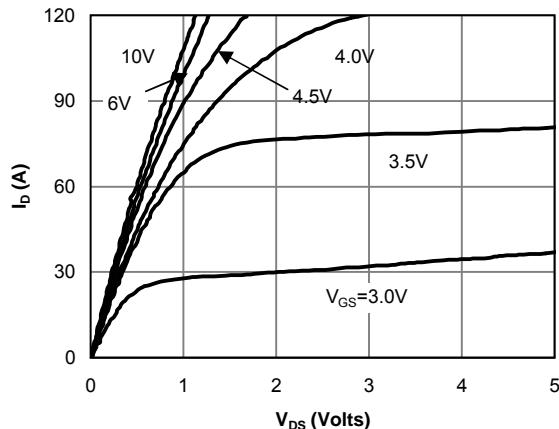
H. Surface mounted on a 1 in 2 FR-4 board with 2oz. Copper.

I. The maximum current rating is limited by bond-wires.

Rev1: Oct. 2006

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



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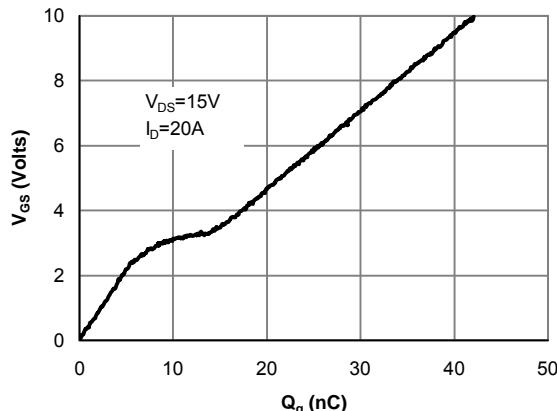


Figure 7: Gate-Charge Characteristics

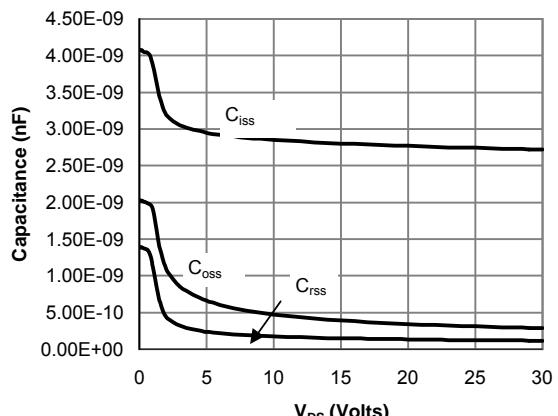


Figure 8: Capacitance Characteristics

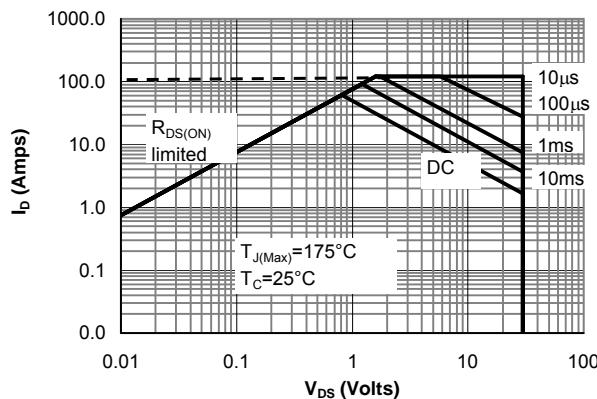


Figure 9: Maximum Forward Biased Safe Operating Area (Note F)

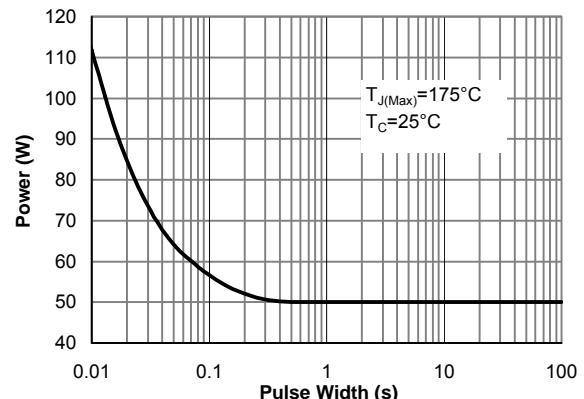


Figure 10: Single Pulse Power Rating Junction-to-Case (Note F)

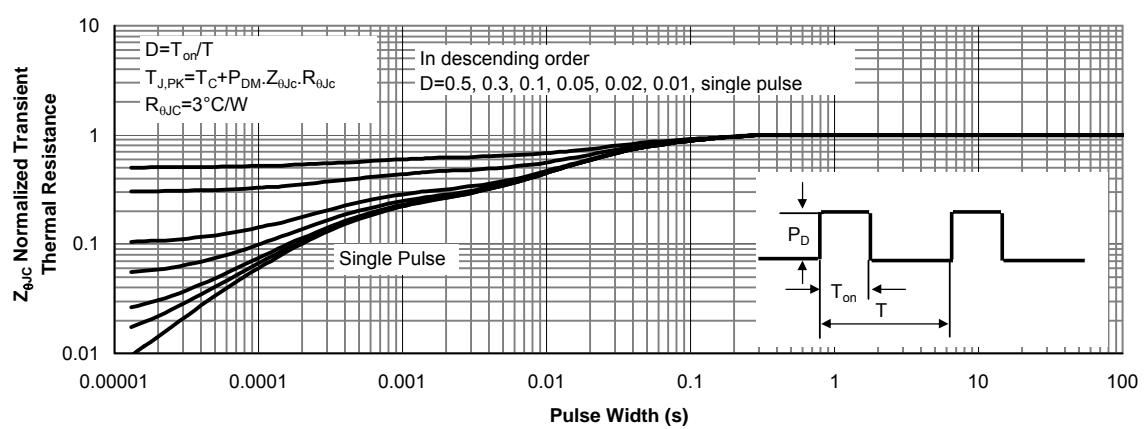


Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

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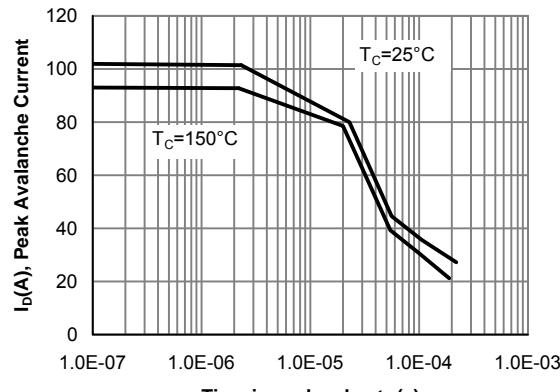


Figure 12: Single Pulse Avalanche capability

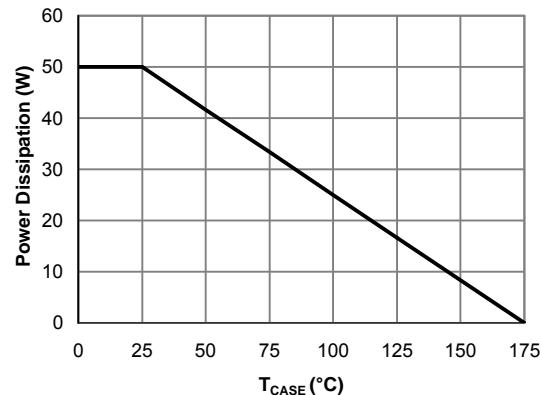


Figure 13: Power De-rating (Note B)

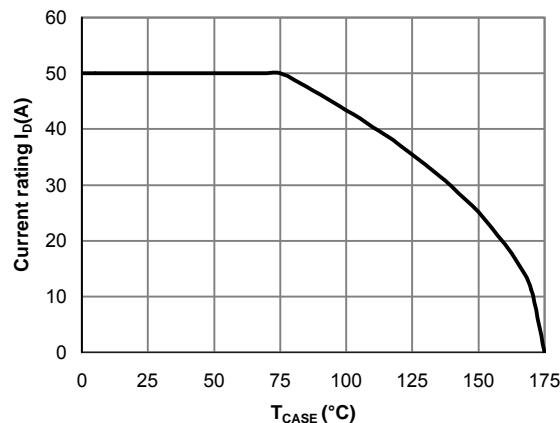


Figure 14: Current De-rating (Note B)

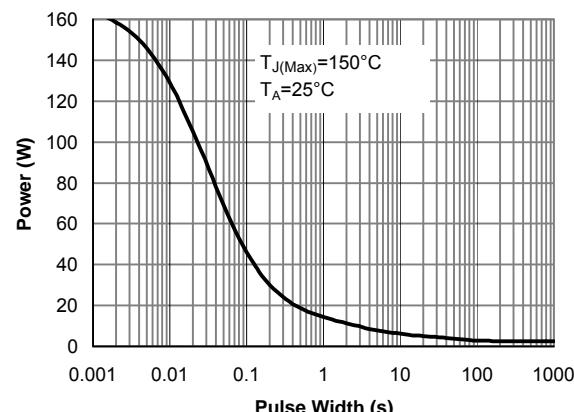


Figure 15: Single Pulse Power Rating Junction-to-Ambient (Note G)

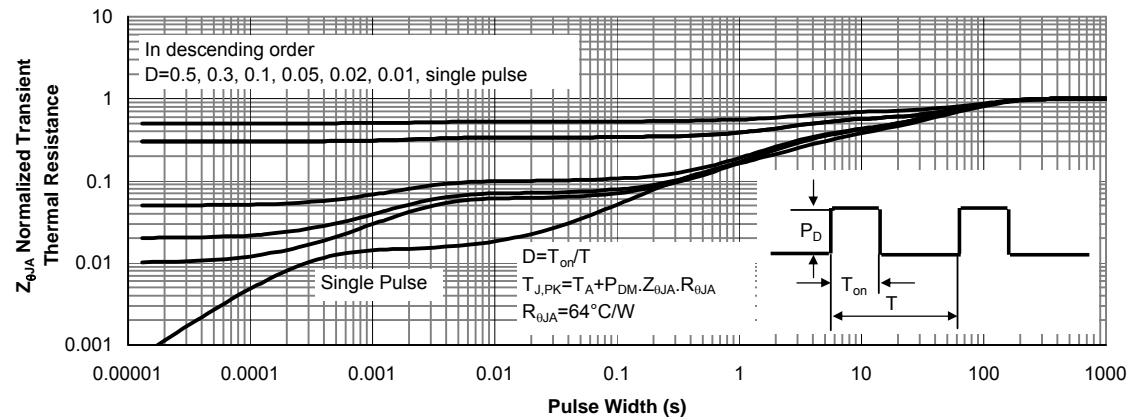


Figure 16: Normalized Maximum Transient Thermal Impedance (Note G)

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